Random bad cell map for wafer 171 s/n: Y21316-12-07

Date: 07/06/99

		3	0	1		0		
		2	0			3		
	0	0	2	8	7		18	
	0	5	2		17	7		
	0	1	20	91	50	4	0	4
0	0		97	270		18	4	7
0	0	12	322	344		37	7	
0	0	35	479	164		55	2	0
		39	260	19	264	68	2	
0		43	156	58	255	75	7	
0	0	19	123	53	228	60	0	361
46	0	7	82	119	205	26	0	1
0	0	5	23	86	77		0	2
0	1	3	15	36		6		
	0	0		11	7		2	
	0	0		4			1	
				0	1	10		
			0	3	3			

#	Number of bad cells in random locations
	No info